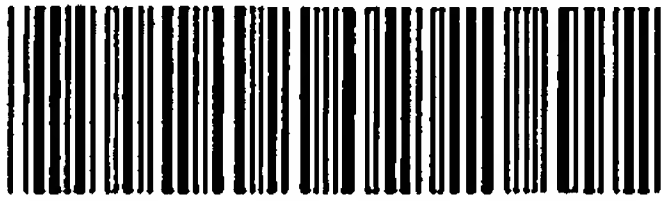


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/652,134	MAY ET AL.	
	Examiner	Art Unit	
	Daniel Pan	2183	

SEARCHED			
Class	Subclass	Date	Examiner
712	7 224	1/29/2006	DP
<i>updated</i>		<i>8/1/00</i>	<i>R</i>

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
west pgp uspat jopabs epoabs derwent ibm ieee npl 712/3 bit insert 710/68 comp. 711/173 part.	1/29/2006	DP
<i>update</i> →	<i>8/1/00</i>	<i>R</i>